$\frac{\text{MOSFET}}{\text{SUPERFET}^{\mathbb{R}}} - \text{N-Channel,}$ $\text{SUPERFET}^{\mathbb{R}}, \text{ FRFET}^{\mathbb{R}}$ $\text{600 V, 47 A, 73 m}\Omega$

FCH47N60F

Description

SUPERFET MOSFET is ON Semiconductor's first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SUPERFET MOSFET is very suitable for the switching power applications such as PFC, server / telecom power, FPD TV power, ATX power and industrial power applications. SUPERFET FRFET MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.

Features

- 650 V @ T_J = 150°C
- Typ. $R_{DS(on)} = 58 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Qg = 210 nC)
- Low Effective Output Capacitance (Typ. Cosseff. = 420 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

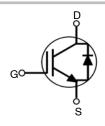
- Solar Inventer
- AC-DC Power Supply



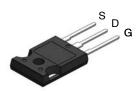
ON Semiconductor®

www.onsemi.com

V _{DS}	R _{DS(ON)} MAX	I _D MAX
600 V	73 mΩ @ 10 V	47 A

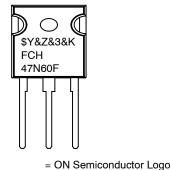


N-CHANNEL MOSFET



TO-247-3LD CASE 340CK

MARKING DIAGRAM



\$Y

=

&Z &3 Assembly Plant CodeNumeric Date Code

&K

= Lot Code

FCH47N60F

= Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C unless otherwise noted)

Symbol	Parameter		FCH47N60F-F133	Unit
V _{DSS}	Drain to Source Voltage		600	V
Ι _D		ontinuous (T _C = 25°C) ontinuous (T _C = 100°C)	47 29.7	A A
I _{DM}	Drain Current -Pu	ulsed (Note 1)	141	Α
V_{GSS}	Gate-Source Voltage		±30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		1800	mJ
I _{AR}	Avalanche Current (Note 1)		47	А
E _{AR}	Repetitive Avalanche Energy (Note 1)		41.7	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		50	V/ns
P_{D}	, , ,	_C = 25°C) erate Above 25°C	417 3.33	W W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to + 150	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/2	from Case for 5 second	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. $I_{AS} = 18 \text{ A}$, $V_{DD} = 50 \text{ V}$, $R_G = 25 \Omega$, Starting $T_J = 25 ^{\circ}C$ 3. $I_{SD} \le 47 \text{ A}$, I_{S

PACKAGE MARKING AND ORDERING INFORMATION

Device Mark	cing Devi	ice Package	Reel Size	Tape Width	Quantity
FCH47N60	FCH47N6	0F-F133 TO-247-3	-	-	30 Units

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.3	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 34)	41.7	

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARA	ACTERISTICS	•		•		
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}, T_J = 25^{\circ}\text{C}$	600	-	-	V
		I _D = 250 μA, V _{GS} = 0 V, T _J = 150°C	-	650	_	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C	-	0.6	_	V/°C
BV _{DS}	Drain-Source Avalanche Breakdown Voltage	I _D = 47 A, V _{GS} = 0 V	-	700	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V, V _{GS} = 0 V	_	-	10	μΑ
		V _{DS} = 480 V, T _C = 125°C	_	-	100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V	-	-	-100	nA
ON CHARA	CTERISTICS	•	•	-	<u>-</u>	<u>-</u>
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	_	5	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 23.5 A	-	0.062	0.073	Ω
9FS	Forward Transconductance	V _{DS} = 40 V, I _D = 23.5 A	-	40	_	S
DYNAMIC C	HARACTERISTICS				-	
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,	_	5900	8000	pF
C _{oss}	Output Capacitance	f = 1 MHz	-	3200	4200	pF
C _{rss}	Reverse Transfer Capacitance	1	_	250	-	pF
C _{oss}	Output Capacitance	V _{DS} = 480 V, V _{GS} = 0 V, f = 1 MHz	-	160	-	pF
C _{oss} eff.	Effective Output Capacitance	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	420	-	pF
SWITCHING	CHARACTERISTICS				-	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 300 \text{ V}, I_D = 47 \text{ A},$	_	185	430	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4)	-	210	450	ns
t _{d(off)}	Turn-Off Delay Time	(1010 1)	-	520	1100	ns
t _f	Turn-Off Fall Time	1	-	75	160	ns
Qg	Total Gate Charge	$V_{DS} = 480 \text{ V}, I_D = 47 \text{ A},$	_	210	270	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4)	-	38	_	nC
Q _{gd}	Gate-Drain Charge	(1010 1)	-	110	_	nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND N	IAXIMUM RATINGS	-			
I _S	Maximum Continuous Drain-Source Diode Forward Current		_	_	47	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		_	-	141	Α
V _{SD}	Source to Drain Diode Voltage	V _{GS} = 0 V, I _S = 47 A	_	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 47 A,	_	240	-	ns
	Reverse Recovery Charge	dl _F /dt = 100 A/μs		2.04		μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially Independent of Operating Temperature Typical Characteristics.

TYPICAL CHARACTERISTICS

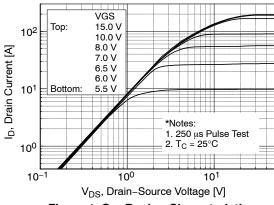


Figure 1. On-Region Characteristics

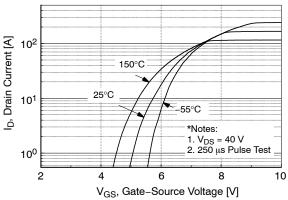


Figure 2. Transfer Characteristics

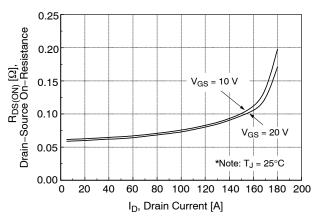


Figure 3. On-Resistance Variation vs. Drain Current and Gate voltage

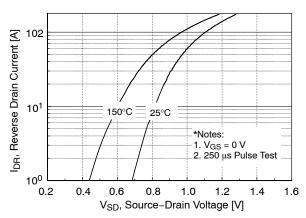


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

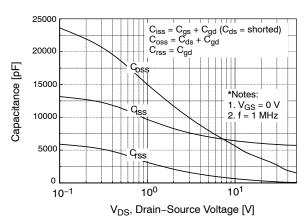


Figure 5. Capacitance Characteristics

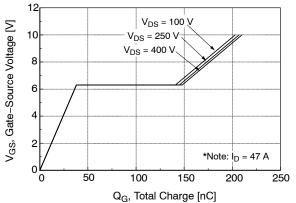


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS

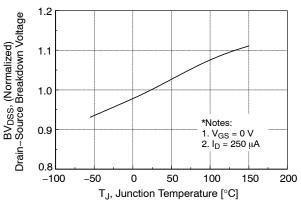


Figure 7. Breakdown Voltage Variation vs. Temperature

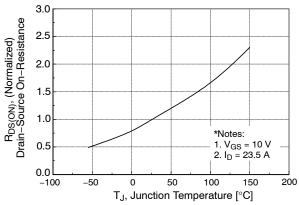


Figure 8. On–Resistance Variation vs. Temperature

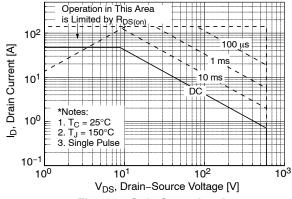


Figure 9. Safe Operating Area

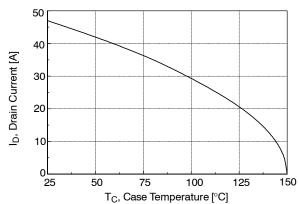


Figure 10. Maximum Drain Current vs. Case Temperature

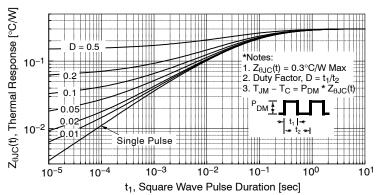


Figure 11. Transient Thermal Response Curve

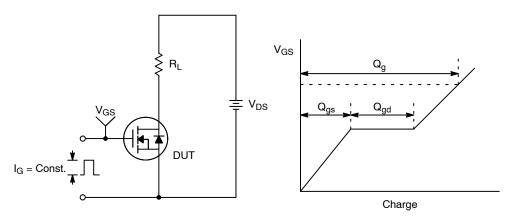


Figure 12. Gate Charge Test Circuit & Waveform

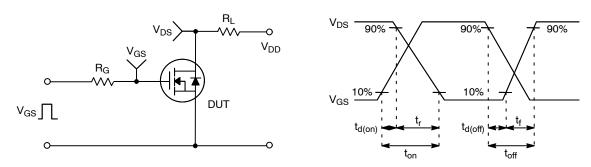


Figure 13. Resistive Switching Test Circuit & Waveforms

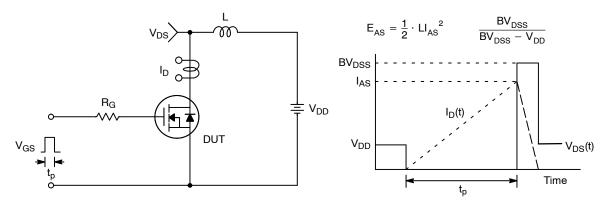


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

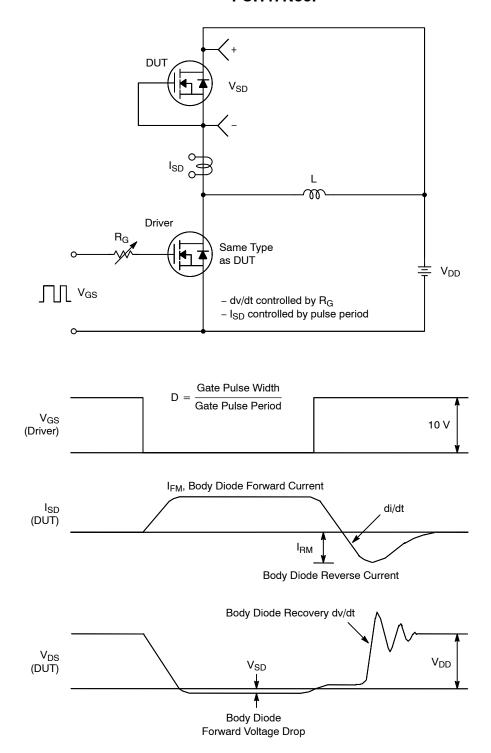


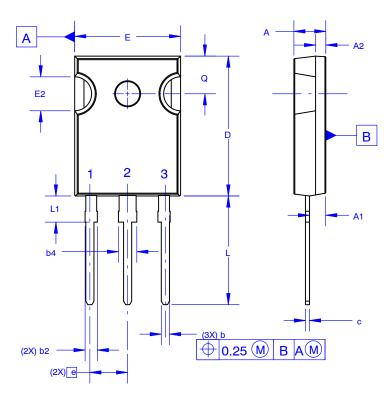
Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

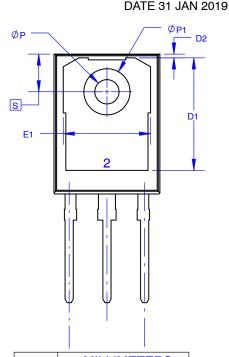
A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MIL	LIMET	ERS
DIIVI	MIN	NOM	MAX
Α	4.58	4.70	4.82
A1	2.20	2.40	2.60
A2	1.40	1.50	1.60
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
С	0.51	0.61	0.71
D	20.32	20.57	20.82
D1	13.08	~	~
D2	0.51	0.93	1.35
E	15.37	15.62	15.87
E1	12.81	~	~
E2	4.96	5.08	5.20
е	~	5.56	~
L	15.75	16.00	16.25
L1	3.69	3.81	3.93
ØΡ	3.51	3.58	3.65
ØP1	6.60	6.80	7.00
Q	5.34	5.46	5.58
S	5.34	5.46	5.58

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DESCRIPTION:	TO-247-3LD SHORT LEAD		PAGE 1 OF 1	

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